General Description

The MAX9392/MAX9393 dual 2 x 2 crosspoint switches perform high-speed, low-power, and low-noise signal distribution. The MAX9392/MAX9393 multiplex one of two differential input pairs to either or both low-voltage differential signaling (LVDS) outputs for each channel. Independent enable inputs turn on or turn off each differential output pair.

Four LVCMOS/LVTTL logic inputs (two per channel) control the internal connections between inputs and outputs. This flexibility allows for the following configurations: 2 x 2 crosspoint switch, 2:1 mux, 1:2 splitter, or dual repeater. This makes the MAX9392/MAX9393 ideal for protection switching in fault-tolerant systems, loopback switching for diagnostics, fanout buffering for clock/data distribution, and signal regeneration.

Fail-safe circuitry forces the outputs to a differential low condition for undriven inputs or when the commonmode voltage exceeds the specified range. The MAX9392 provides high-level input fail-safe detection for LVDS, HSTL, and other GND-referenced differential inputs. The MAX9393 provides low-level input fail-safe detection for LVPECL, CML, and other V_{CC}-referenced differential inputs.

Ultra-low 98ps(P-P) (max) pseudorandom bit sequence (PRBS) jitter ensures reliable communications in high-speed links that are highly sensitive to timing error, especially those incorporating clock-and-data recovery, or serializers and deserializers. The high-speed switching performance guarantees 1.5GHz operation and less than 67ps (max) skew between channels.

LVDS inputs and outputs are compatible with the TIA/EIA-644 LVDS standard. The LVDS outputs drive 100 Ω loads. The MAX9392/MAX9393 are offered in 5mm x 5mm thin QFN with exposed paddle and 32-pin TQFP packages and operate over the extended temperature range (-40°C to +85°C).

Also see the MAX9390/MAX9391 for the crossflow version.

Applications High-Speed Telecom/Datacom Equipment Central-Office Backplane Clock Distribution DSLAM Protection Switching Fault-Tolerant Systems

Functional Diagram and Typical Operating Circuit appear at end of data sheet.

Features

- 1.5GHz Operation with 250mV Differential Output Swing
- ◆ 2ps_{RMS} (max) Random Jitter
- AC Specifications Guaranteed for 150mV Differential Input
- Signal Inputs Accept Any Differential Signaling Standard
- LVDS Outputs for Clock or High-Speed Data
- High-Level Input Fail-Safe Detection (MAX9392)
- Low-Level Input Fail-Safe Detection (MAX9393)
- ♦ +3.0V to +3.6V Supply Voltage Range
- LVCMOS/LVTTL Logic Inputs Control Signal Routing

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX9392EHJ	-40°C to +85°C	32 TQFP
MAX9392ETJ*	-40°C to +85°C	32 Thin QFN
MAX9393EHJ	-40°C to +85°C	32 TQFP
MAX9393ETJ*	-40°C to +85°C	32 Thin QFN

*Future product—contact factory for availability.

Pin Configurations TOP VIEW ASELO 29 29 INA1 INA1 INAO INAO GND 31 30 32 28 27 26 25 GND 1 24 Vcc INB0 2 23 OUTA0 INB0 3 22 OUTAO NIXIM 21 ENA0 BSEL0 4 MAX9392 20 GND V_{CC} 5 MAX9393 19 OUTA1 INB1 6 INB1 7 18 OUTA1 17 ENA1 BSEL1 8 9 10 11 14 15 16 12 <u>OUTBO</u> OUTBO GND ENBO VCC **UTB1 UTB1** ENB1 TQFP Pin Configurations continued at end of data sheet.

Maxim Integrated Products 1

For pricing, delivery, and ordering information, please contact Maxim/Dallas Direct! at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

ABSOLUTE MAXIMUM RATINGS

V _{CC} to GND0.	3V to +4.1V
IN, ĪN, OUT, OUT, EN,	
SEL to GND0.3V to (\	√ _{CC} + 0.3V)
IN to TN	±3V
Short-Circuit Duration (OUT, OUT)	.Continuous
Continuous Power Dissipation ($T_A = +70^{\circ}C$)	
32-Pin TQFP (derate 13.1mW/°C	
above +70°C)	1047mW
32-Pin 5mm x 5mm Thin QFN (derate 21.3mW/°C	
above +70°C)	1702mW

Junction-to-Ambient Thermal Resistance in	n Still Air
32-Pin TQFP	+76.4°C/W
32-Pin 5mm x 5mm Thin QFN	+47°C/W
Junction-to-Case Thermal Resistance	
32-Pin 5mm x 5mm Thin QFN	+2°C/W
Operating Temperature Range	40°C to +85°C
Junction Temperature	+150°C
Storage Temperature Range	65°C to +150°C
Soldering Temperature (10s)	+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = +3.0V \text{ to } +3.6V, R_L = 100\Omega \pm 1\%, EN_ = V_{CC}, V_{CM} = 0.05V \text{ to } (V_{CC} - 0.6V) \text{ (MAX9392)}, V_{CM} = 0.6V \text{ to } (V_{CC} - 0.05V) \text{ (MAX9393)}, T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted}. Typical values are at V_{CC} = +3.3V, IV_{IDI} = 0.2V, V_{CM} = +1.2V, T_A = +25^{\circ}C, \text{ unless otherwise noted}.$ (Notes 1, 2, and 3)

PARAMETER	SYMBOL	CONDITIONS			ТҮР	MAX	UNITS			
LVCMOS/LVTTL INPUTS (EN, _SEL_)										
Input High Voltage	VIH			2.0		V _{CC}	V			
Input Low Voltage	VIL			0		0.8	V			
Input High Current	IIH	$V_{IN} = +2.0V$ to	V _{CC}	0		20	μA			
Input Low Current	١L	$V_{IN} = 0$ to +0.8	3V	0		10	μΑ			
DIFFERENTIAL INPUTS (IN, $\overline{IN_{-}}$)										
Differential Input Voltage	VID	$V_{ILD} \ge 0$ and V	$HD \leq V_{CC}$, Figure 1	0.1		3.0	V			
Input Common Made Pango	Vou	MAX9392		0.05		V _{CC} - 0.6	V			
Input Common-mode hange	V CM	MAX9393		0.6		V _{CC} - 0.05				
Input Current	l _{IN} ,	MAX9392	$ V_{ID} \le 3.0V$	-50		+10	μA			
Input Current	IIN	MAX9393	$ V_{ID} \le 3.0V$	-10		+90				
LVDS OUTPUTS (OUT, OUT)										
Differential Output Voltage	VOD	$R_L = 100\Omega$, Fig	jure 2	250	350	450	mV			
Change in Magnitude of V _{OD} Between Complementary Output States	ΔV_{OD}	Figure 2			1.0	50	mV			
Offset Common-Mode Voltage	V _{OS}	Figure 2		1.125	1.25	1.375	V			
Change in Magnitude of V _{OS} Between Complementary Output States	ΔV _{OS}	Figure 2			1.0	50	mV			

DC ELECTRICAL CHARACTERISTICS (continued)

 $(V_{CC} = +3.0V \text{ to } +3.6V, \text{ R}_{L} = 100\Omega \pm 1\%, \text{ EN}_{_} = \text{V}_{CC}, \text{V}_{CM} = 0.05V \text{ to } (V_{CC} - 0.6V) \text{ (MAX9392)}, \text{V}_{CM} = 0.6V \text{ to } (V_{CC} - 0.05V) \text{ (MAX9393)}, \text{T}_{A} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}, \text{ unless otherwise noted}. Typical values are at V_{CC} = +3.3V, |V_{ID}| = 0.2V, \text{V}_{CM} = +1.2V, \text{T}_{A} = +25^{\circ}\text{C}, \text{ unless otherwise noted}. (Notes 1, 2, and 3)$

PARAMETER	SYMBOL	CONDITIONS		MIN	ΤΥΡ	MAX	UNITS	
Output Short-Circuit Current	llaal	$V_{ID} = \pm 100 \text{mV}$	$V_{OUT_o} or V_{OUT_o} = 0$		30	40	m ^	
(Either Output Shorted to GND)	IIOSI	(Note 4)	$V_{OUT_{-}} = V_{OUT_{-}} = 0$		18	24	ШA	
Output Short-Circuit Current (Outputs Shorted Together)	ll _{OSB} l	$V_{ID} = \pm 100 \text{mV}, V_{OUT} = V_{OUT}$ (Note 4)			5.0	12	mA	
SUPPLY CURRENT								
Supply Current	ICC	$R_L = 100\Omega$, EN	= V _{CC}		68	98	mA	

AC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = +3.0V \text{ to } +3.6V, f_{IN} \leq 1.34GHz, t_{R_{-}IN} = t_{F_{-}IN} = 125\text{ps}, R_{L} = 100\Omega \pm 1\%, |V_{ID}| \geq 150\text{mV}, V_{CM} = +0.075V \text{ to } (V_{CC} - 0.6V) \\ (MAX9392 \text{ only}), V_{CM} = +0.6V \text{ to } (V_{CC} - 0.075V) (MAX9393 \text{ only}), EN_{-} = V_{CC}, T_{A} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}, \text{ unless otherwise noted}. Typical values are at V_{CC} = +3.3V, |V_{ID}| = 0.2V, V_{CM} = +1.2V, f_{IN} = 1.34GHz, T_{A} = +25^{\circ}\text{C}, \text{ unless otherwise noted}.) (Note 5)$

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS
SEL to Switched Output	t SWITCH	Figure 3			1.1	ns
Disable Time to Differential Output Low	^t PHD	Figure 4			1.7	ns
Enable Time to Differential Output High	^t PDH	Figure 4			1.7	ns
Switching Frequency	fMAX	$V_{OD} \ge 250 \text{mV}$	1.5	2.2		GHz
Low-to-High Propagation Delay	t PLH	Figures 1, 5	294	410	574	ps
High-to-Low Propagation Delay	t PHL	Figures 1, 5	286	402	555	ps
Pulse Skew It _{PLH} - t _{PHL} I	t SKEW	Figures 1, 5 (Note 6)		17	104	ps
Output-to-Output Skew	tccs	Figures 5, 6 (Note 7)		4	67	ps
Output Low-to-High Transition Time (20% to 80%)	tR	Figures 1, 5; f _{IN} = 100MHz	112	142	185	ps
Output High-to-Low Transition Time (80% to 20%)	tF	Figures 1, 5; f _{IN} = 100MHz	112	145	185	ps
Added Random Jitter	t _{RJ}	$f_{IN_{}} = 1.34GHz$, clock pattern (Note 8)			2	ps _{RMS}
Added Deterministic Jitter	tDJ	1.34Gbps, 2 ²³ - 1 PRBS (Note 8)		60	98	psp-p

Note 1: Measurements obtained with the device in thermal equilibrium. All voltages referenced to GND except V_{ID} , V_{OD} , and ΔV_{OD} . **Note 2:** Current into the device defined as positive. Current out of the device defined as negative.

Note 3: DC parameters tested at $T_A = +25^{\circ}C$ and guaranteed by design and characterization for $T_A = -40^{\circ}C$ to $+85^{\circ}C$.

Note 4: Current through either output.

Note 5: Guaranteed by design and characterization. Limits set at ±6 sigma.

Note 6: t_{SKEW} is the magnitude difference of differential propagation delays for the same output over same conditions. t_{SKEW} = lt_{PHL} - t_{PLH}.

Note 7: Measured between outputs of the same device at the signal crossing points for a same-edge transition, under the same conditions.

Note 8: Device jitter added to the differential input signal.





MAX9392/MAX9393

Pin Description

PIN	NAME	FUNCTION
1, 12, 20, 25	GND	Ground
2	INB0	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Noninverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
3	ĪNB0	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Inverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
4	BSEL0	Input Select for B0 Output. Selects the differential input to reproduce at the B0 differential outputs. Connect BSEL0 to GND or leave open to select the INB0 (INB0) set of inputs. Connect BSEL0 to V _{CC} to select the INB1 (INB1) set of inputs. An internal $435k\Omega$ resistor pulls BSEL0 low when unconnected.
5, 16, 24, 29	V _{CC}	Power-Supply Input. Bypass each V _{CC} to GND with 0.1μ F and 0.01μ F ceramic capacitors. Install both bypass capacitors as close to the device as possible, with the 0.01μ F capacitor closest to the device.
6	INB1	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Noninverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
7	ĪNB1	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Inverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
8	BSEL1	Input Select for B1 Output. Selects the differential input to reproduce at the B1 differential outputs. Connect BSEL1 to GND or leave open to select the INB0 (INB0) set of inputs. Connect BSEL1 to V _{CC} to select the INB1 (INB1) set of inputs. An internal $435k\Omega$ resistor pulls BSEL1 low when unconnected.
9	ENB1	B1 Output Enable. Drive ENB1 high to enable the B1 LVDS outputs. An internal 435k Ω resistor pulls ENB1 low when unconnected.
10	OUTB1	B1 LVDS Inverting Output. Connect a 100 Ω termination resistor between OUTB1 and $\overline{\text{OUTB1}}$ at the receiver inputs to ensure proper operation.
11	OUTB1	B1 LVDS Noninverting Output. Connect a 100Ω termination resistor between OUTB1 and $\overline{OUTB1}$ at the receiver inputs to ensure proper operation.
13	ENB0	B0 Output Enable. Drive ENB0 high to enable the B0 LVDS outputs. An internal 435 k Ω resistor pulls ENB0 low when unconnected.
14	OUTB0	B0 LVDS Inverting Output. Connect a 100Ω termination resistor between OUTB0 and $\overline{\text{OUTB0}}$ at the receiver inputs to ensure proper operation.
15	OUTB0	B0 LVDS Noninverting Output. Connect a 100Ω termination resistor between OUTB0 and $\overline{OUTB0}$ at the receiver inputs to ensure proper operation.

Pin Description (continued)

	-	
PIN	NAME	FUNCTION
17	ENA1	A1 Output Enable. Drive ENA1 high to enable the A1 LVDS outputs. An internal $435k\Omega$ resistor pulls ENA1 low when unconnected.
18	OUTA1	A1 LVDS Inverting Output. Connect a 100 Ω termination resistor between OUTA1 and $\overline{\text{OUTA1}}$ at the receiver inputs to ensure proper operation.
19	OUTA1	A1 LVDS Noninverting Output. Connect a 100Ω termination resistor between OUTA1 and $\overline{\text{OUTA1}}$ at the receiver inputs to ensure proper operation.
21	ENA0	A0 Output Enable. Drive ENA0 high to enable the A0 LVDS outputs. An internal $435k\Omega$ resistor pulls ENA0 low when unconnected.
22	OUTAO	A0 LVDS Inverting Output. Connect a 100 Ω termination resistor between OUTA0 and $\overline{\text{OUTA0}}$ at the receiver inputs to ensure proper operation.
23	OUTA0	A0 LVDS Noninverting Output. Connect a 100Ω termination resistor between OUTA0 and $\overline{OUTA0}$ at the receiver inputs to ensure proper operation.
26	INA0	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Noninverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
27	ĪNA0	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Inverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
28	ASELO	Input Select for A0 Output. Selects the differential input to reproduce at the A0 differential outputs. Connect ASEL0 to GND or leave open to select the INA0 (INA0) set of inputs. Connect ASEL0 to V _{CC} to select the INA1 (INA1) set of inputs. An internal $435k\Omega$ resistor pulls ASEL0 low when unconnected.
30	INA1	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Noninverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
31	ĪNA1	LVDS/HSTL (MAX9392) or LVPECL/CML (MAX9393) Inverting Input. An internal 128k Ω resistor to V _{CC} pulls the input high when unconnected (MAX9392). An internal 68k Ω resistor to GND pulls the input low when unconnected (MAX9393).
32	ASEL1	Input Select for A1 Output. Selects the differential input to reproduce at the A1 differential outputs. Connect ASEL1 to GND or leave open to select the INA0 (INA0) set of inputs. Connect ASEL1 to V _{CC} to select the INA1 (INA1) set of inputs. An internal $435k\Omega$ resistor pulls ASEL1 low when unconnected.
_	EP	Exposed Paddle (QFN Package Only). Connect to GND for optimal thermal and EMI characteristics.





Figure 1. Output Transition Time and Propagation Delay Timing Diagram

Figure 2. Test Circuit for VOD and VOS



Figure 3. Input to Rising/Falling Edge Select and Mux Switch Timing Diagram



Figure 4. Output Active-to-Disable and Disable-to-Active Test Circuit and Timing Diagram



Figure 5. Output Transition Time, Propagation Delay, and Output Channel-to-Channel Skew Test Circuit

MAX9392/MAX9393



Figure 6. Output Channel-to-Channel Skew

Detailed Description

The LVDS interface standard provides a signaling method for point-to-point communication over a controlled-impedance medium as defined by the ANSI TIA/EIA-644 standard. LVDS utilizes a lower voltage swing than other communication standards, achieving higher data rates with reduced power consumption, while reducing EMI emissions and system susceptibility to noise.

The MAX9392/MAX9393 1.5GHz dual 2 x 2 crosspoint switches optimize high-speed, low-power, point-to-point interfaces. The MAX9392 accepts LVDS and HSTL signals, while the MAX9393 accepts LVPECL and CML signals. Both devices route the input signals to either or both LVDS outputs.

When configured as a 1:2 splitter, the outputs repeat the selected inputs. This configuration creates copies of signals for protection switching. When configured as a repeater, the device operates as a two-channel buffer. Repeating restores signal amplitude, allowing isolation of media segments or longer media drive. When configured as a 2:1 mux, select primary or backup signals to provide a protection-switched, fault-tolerant application.

Input Fail-Safe The differential inputs of the MAX9392/MAX9393 possess internal fail-safe protection. Fail-safe circuitry forces the outputs to a differential low condition for undriven inputs or when the common-mode voltage exceeds the specified range. The MAX9392 provides high-level input fail-safe detection for LVDS, HSTL, and other GND-referenced differential inputs. The MAX9393 provides low-level input fail-safe detection for LVPECL, CML, and other V_{CC}-referenced differential inputs.





Figure 7. Programmable Configurations

Select Function

The _SEL_ logic inputs control the input and output signal connections. Two logic inputs control the signal routing for each channel. _SEL0 and _SEL1 allow the devices to be configured as a differential crosspoint switch, 2:1 mux, dual repeater, or 1:2 splitter (Figure 7). See Table 1 for mode-selection settings (insert A or B for the _). Channels A and B possess separate select inputs, allowing different configurations for each channel.

Enable Function

The EN_ _ logic inputs enable and disable each set of differential outputs. Connect EN_ 0 to V_{CC} to enable the OUT_0/OUT_0 differential output pair. Connect EN_0 to GND to disable the OUT_0/OUT_0 differential output pairs assert to a differential low condition when disabled.

_SEL0)	_SEL1	OUT_0 /	OUT_0
0		0	IN_0 /	ĪN_0
0		1	IN_0 /	ĪN_0
1		0	IN_1 /	ĪN_1
1		1	IN_1 /	ĪN_1
	_Appli	ications Inform Differential	nation I Inputs	Term

Table 1 Input/Output Function Table

The MAX9392/MAX9393 inputs accept any differential signaling standard within the specified common-mode voltage range. The fail-safe feature detects commonmode input signal levels and generates a differential output low condition for undriven inputs or when the common-mode voltage exceeds the specified range. Leave unused inputs unconnected or connect to V_{CC} for the MAX9392 or to GND for the MAX9393.

Expanding the Number of LVDS Output Ports

Cascade devices to make larger switches. Consider the total propagation delay and total jitter when determining the maximum allowable switch size.

Power-Supply Bypassing

Bypass each V_{CC} to GND with high-frequency surfacemount ceramic 0.1µF and 0.01µF capacitors in parallel as close to the device as possible. Install the 0.01µF capacitor closest to the device.

Differential Traces

Input and output trace characteristics affect the performance of the MAX9392/MAX9393. Connect each input and output to a 50 Ω characteristic impedance trace. Maintain the distance between differential traces and eliminate sharp corners to avoid discontinuities in differential impedance and maximize common-mode noise immunity. Minimize the number of vias on the differential input and output traces to prevent impedance discontinuities. Reduce reflections by maintaining the 50Ω characteristic impedance through connectors and across cables. Minimize skew by matching the electrical length of the traces.

Output Termination

MODE

1:2 splitter

Repeater

Switch

1:2 splitter

erminate LVDS outputs with a 100 Ω resistor between the differential outputs at the receiver inputs. LVDS outputs require 100Ω termination for proper operation.

OUT_1/OUT_1

 $IN O / \overline{IN} \overline{O}$

 IN_1 / \overline{IN}_1

 $IN_0 / \overline{IN}_\overline{0}$

 $IN_1 / \overline{IN_1}$

Ensure that the output currents do not exceed the current limits specified in the Absolute Maximum Ratings. Observe the total thermal limits of the MAX9392/ MAX9393 under all operating conditions.

Cables and Connectors

Use matched differential impedance for transmission media. Use cables and connectors with matched differential impedance to minimize impedance discontinuities. Avoid the use of unbalanced cables. Balanced cables such as twisted pair offer superior signal quality and tend to generate less EMI due to canceling effects.

Board Layout

Use a four-layer printed circuit (PC) board providing separate signal, power, and ground planes for highspeed signaling applications. Bypass V_{CC} to GND as close to the device as possible. Install termination resistors as close to receiver inputs as possible. Match the electrical length of the differential traces to minimize signal skew.

Typical Operating Circuit





Functional Diagram



TOP VIEW ASELO ASEL⁻ **INA0** NA0 NA1 INA1 GND 00/ 28 32 30 27 26 25 • GND 1 24 V_{CC} 23 OUTAO INB0 2 22 OUTAO **INBO** 3 M/IXI/M 21 ENA0 BSEL0 4 MAX9392 V_{CC} 5 20 GND MAX9393 19 OUTA1 INB1 6 18 OUTA1 INB1 7 *EXPOSED PADDLE 17 ENA1 BSEL1 8 9 10 11 12 13 14 15 16 OUTBO <u>outbo</u> ENB1 <u>JUTB1</u> OUTB1 GND ENBO Vcc THIN QFN (5mm x 5mm) *CONNECT EXPOSED PADDLE TO GND.

Chip Information

TRANSISTOR COUNT: 1565 PROCESS: Bipolar

Pin Configurations (continued)

Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to **www.maxim-ic.com/packages**.)



Package Information (continued)

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to <u>www.maxim-ic.com/packages</u>.)



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14

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